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Zn interstitials and O vacancies responsible for n-type ZnO: what do the emission spectra reveal?†

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Zinc interstitials and their complexes with oxygen vacancies, harbouring a lone pair of electrons, have been discussed as suspects for an n-type character and the ensuing conductivity of nominally undoped ZnO. ZnO nanorods, with different Zn concentrations, have been studied using photoluminescence and photoluminescence excitation spectroscopy to evidence the presence of defect states, their correlation with excess Zn and their viability as donors. It is shown that each sample may emit intense violet-blue, green-orange and red emissions, as decided by the excitation energy and presence of excess Zn. Intensity variation of these individual emissions *vis-à-vis* their excitation energies, in the range 4.0–2.7 eV, indicates the presence of defect states not only within the band gap but crucially within the conduction band itself, but only in a Zn rich environment. The study provides the experimental signature of the theoretical predictions of the latter states and demonstrates why Zn interstitials may be responsible for the n-type doping and conductivity of ZnO. The origin of the emissions, their interdependence and tunability are further discussed.

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1. Introduction

Its wide direct band gap (3.4 eV) and high exciton binding energy has made ZnO¹ a promising candidate for varied optoelectronic applications,^{2,3} primary among which is its utility as a transparent but conducting medium.^{4,5} While most forms of undoped ZnO, at room temperature (RT), show n-type character, p-type ZnO is rarely prepared, intentionally or otherwise.^{1,6} The debate as to the origin of this n-type character and the associated donor states has mostly centred around two doubly occupied contenders; the oxygen vacancy (V_O) states and interstitial Zn (I_{Zn}) related defect states. Understanding this origin is vital, not only for tailoring ZnO for varied applications but also to gain a basic insight into the physics of doping ZnO – even in preparing its p-type counterpart. Based on existing literature we can summarize the current understanding about the likely origin of the n-type nature of ZnO as follows. Complexes of the deep level V_O and the shallower I_{Zn} states, formed by their hybridization, may be responsible for the formation of effective donor states, rather than the isolated I_{Zn} and V_O defect states themselves.^{7–9} However, even these hybridized states may be effective donors only if they energetically lie either close to the conduction band (CB) minima, with ionization energies comparable to RT,^{10–13} or within the CB itself.^{7,14} This study investigates the role of excess Zn in forming

the I_{Zn} related donor states in ZnO, as evidenced through photoluminescence (PL) and photoluminescence excitation (PLE) studies on ZnO nanorods with differential I_{Zn} density.

Exciton recombination is the primary channel of PL in ZnO, where the exciton binding energy is larger than the thermal energy. Electrons excited into the CB from the valence band (VB) undergo relaxation to the conduction band minimum (CBM), which, if followed by radiative e–h recombination results in the detected PL. The momentum and energy relaxation path to the CBM is thus strongly correlated to the band structure of the system. The typical PL spectrum of ZnO shows the characteristic near-band-edge (NBE) emission in the UV, along with green-orange emission in the visible range, indicating the presence of defect states lying within the band gap.^{15–23} The I_{Zn} related states lying below the CBM^{10,14} have been shown to give rise to violet-blue emissions¹⁶ that are seldom detected in the PL spectra of ZnO, except in Zn rich conditions and for excitation energies close to, or just less than, the band-gap energy (E_g). The green-orange emissions have been attributed to transitions to and from ionized V_O states, *i.e.* V_O^+ and V_O^{++} states,^{21,24} which effectively manifest at surfaces, interfaces and grain boundaries.^{20,25}

Here, ZnO nanorods with large surface to volume ratio and varying concentrations of Zn have been investigated to study the I_{Zn} related defect states through the emission properties of the nanorods. It is expected that the availability of the surface related V_O defects and excess Zn in the system will create an abundance of I_{Zn} - V_O complexes thus nucleating viable donor states in ZnO, resulting in its n-type character. Evolution of the PL spectra, recorded with varying excitation energy, not only

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confirm the presence of these I_{Zn} related states below the CBM but also provide evidence of I_{Zn} related states within the CB itself, corroborating theoretical calculations.^{7,9}

2. Experimental details

ZnO nanorods grown by two different low temperature techniques, (i) electrochemical deposition (ZnO/ITO) and (ii) oxidation of Zn foil (ZnO/Zn), have been investigated here. The ZnO/ITO nanorods were grown on the seeded²⁶ ITO coated glass substrates (Sigma Aldrich, $70\text{--}100\ \Omega\ \text{sq}^{-1}$) in a two-step electrochemical deposition method.²⁷ Nanorods were grown in a 25 mM equimolar aqueous solution of zinc nitrate hexahydrate (Sigma Aldrich) and hexamethylene-tetramine (Sigma Aldrich) at 95 °C, using platinum as the counter and reference electrode. The substrate was sequentially biased at $-2.73\ \text{V}$ and $-2.15\ \text{V}$, relative to the reference electrode, for 1 and 10 minutes respectively. After deposition, samples were rinsed in deionized water and dried at RT. ZnO nanorods with excess Zn were prepared by oxidizing a piece of zinc foil (99.99%, Alfa Aesar) immersed in deionized water containing 7% (*v/v*) formamide (Sigma-Aldrich), at 65 °C for 24 h.²⁸ The as grown ZnO/Zn nanorods were washed in alcohol and deionized water, prior to drying at RT. Morphological characterization and elemental analysis of the nanorods were performed in Nova Nano SEM 450 field-emission scanning electron microscope (SEM) coupled with an Apollo X energy dispersive X-ray analysis (EDAX) system and in 200 kV TECNAI G2-TF-20 transmission electron microscope (TEM). The X-ray diffraction (XRD) data were collected using a powder X-ray diffractometer (Empyrean, PANalytical) with reference radiation of Cu K_{α} = 1.540 Å at an operating voltage of 45 kV and analyzed using the ICDD PDF4+ database. PL and PLE spectra were recorded for both samples using a spectrofluorometer (Fluorolog 3, Horiba Jobin-Yvon) at RT, without annealing since I_{Zn} related defects are highly mobile even at low temperatures.²⁹

3. Results and discussion

SEM images of *c*-axis oriented, hexagonal ZnO nanorods grown on ITO and Zn foil are shown in Fig. 1(a) and (b). The ZnO/ITO nanorods are not vertically aligned and have an average diameter and length of 40 nm and 900 nm respectively (Fig. 2(a)). The ZnO/Zn nanorods, shown in Fig. 1(b), are vertically oriented and are typically 4 μm long with diameters below 400 nm (Fig. 2(b)). While the XRD spectrum for ZnO/ITO shows a dominant ZnO (002) peak, that for ZnO/Zn nanorods exhibits multiple peaks attributable to Zn (*ed) along with those from ZnO. The XRD data indicate highly oriented *c*-axis growth (wurtzite structure) and a high degree of crystallinity in both samples which can also be confirmed from their corresponding high resolution TEM (HRTEM) images (Fig. 2(c) and (d)) and electron diffraction (SAED) patterns (insets of Fig. 2(c)). Importantly, the purity of the samples is confirmed by the absence of impurity related diffraction peaks in the XRD pattern. SAED patterns can be indexed to the wurtzite structure of hexagonal ZnO and indicate that the nanorods grow along the [001] direction. In the HRTEM



Fig. 1 SEM images of (a) ZnO/ITO and (b) ZnO/Zn nanorods (c) XRD patterns of the respective nanorods.

image (Fig. 2(c) and (d)), the lattice spacing of 0.52 nm also corresponds well to the interplanar distance of the (001) crystal plane of wurtzite ZnO.

Fig. 3(a) shows the EDAX spectra for ZnO/ITO and ZnO/Zn samples, recorded with a beam acceleration voltage (V_A) of 15 kV. Along with the characteristic peaks for Zn and O, the former shows In, Sn and Si peaks generated from the ITO coated glass substrate. Further, EDAX spectra were recorded as a function of V_A (2–20 kV) to investigate the relative variation of Zn and O with depth of the samples. Table 1 shows the relative concentration of Zn and O, obtained at 5 and 15 kV for each sample. The penetration depth of the electron beam, as a function of energy, may be estimated using the Kanaya–Okayama depth penetration formula.³⁰ For pure ZnO, the estimated penetration depths for $V_A = 5$ and 15 kV are 430 nm and 2.5 μm respectively. Consequently, the EDAX counts recorded with $V_A = 5$ kV originate primarily from the nanorods with negligible contribution from the substrates, for both samples. However, for $V_A = 15$ kV the counts arise primarily from the nanorods for ZnO/Zn but not for ZnO/ITO, where there will be a finite contribution from the substrate as well.

At 5 kV, both samples show an O deficient and Zn rich composition, though the Zn percentage is significantly higher in ZnO/Zn compared to ZnO/ITO. At 15 kV, the atomic percentage of Zn is further enhanced in the ZnO/Zn the sample – indicating diffusion from the Zn foil. The higher percentage of O observed for ZnO/ITO, at 15 kV, is likely due to contributions from ITO and glass. Fig. 3(b) shows the variation in relative density of Zn and O along the length of a ZnO/Zn nanorod,

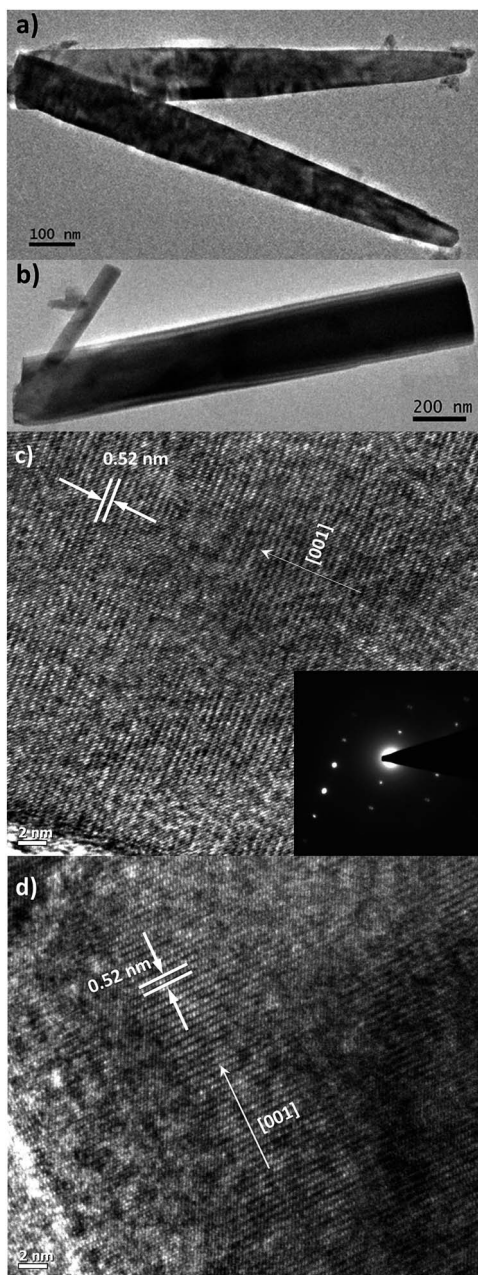


Fig. 2 Low-resolution TEM images of (a) ZnO/ITO and (b) ZnO/Zn nanorods. High-resolution TEM images of (c) ZnO/ITO and (d) ZnO/Zn nanorods. Inset shows the SAED pattern of ZnO/ITO nanorods.

calculated by recording point EDAX spectra along the length of a horizontally placed nanorod. It bears the clear signature of excess Zn towards the base of the nanorod and further confirms that ZnO/Zn nanorods are stoichiometrically Zn rich compared to the ZnO/ITO sample.

The room temperature PL spectra of ZnO/ITO nanorods, recorded with varying excitation wavelengths (λ_{exc}) and energies (E_{exc}) are shown in Fig. 4(a). For excitation energies larger than E_g (i.e. $\lambda_{\text{exc}} \leq 370$ nm) the spectra shows a sharp UV peak at 377 nm (3.3 eV) due to the NBE emission and a broad band emission in the visible range, centred at 615 nm (2.01 eV), attributed to

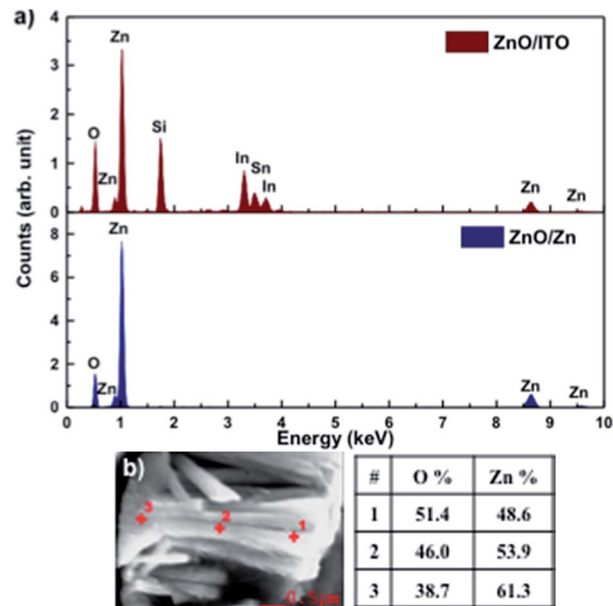


Fig. 3 (a) EDAX spectra of ZnO/ITO and ZnO/Zn nanorods. (b) Atomic percentage of Zn and O at 3 points along the length of a ZnO/Zn nanorod, recorded at 5 kV.

Table 1 Relative atomic percentage of Zn and O in the nanorods at 5 and 15 keV of e-beam energy

Element	Atomic% (5 keV)		Atomic% (15 keV)	
	ZnO/ITO	ZnO/Zn	ZnO/ITO	ZnO/Zn
O	44.6	38.1	55.1	33.4
Zn	55.4	61.9	44.9	66.6

transitions to/from defect states within the band-gap.³¹ The NBE emission at 377 nm yields a band gap of 3.36 eV, including the excitonic correction of 60 meV for the ZnO/ITO sample. As λ_{exc} increases beyond 370 nm, the PL spectrum is substantially modified with the appearance of violet-blue emission in the spectral window 410–470 nm (Fig. 4(a) and (b)), with distinct peaks at 411 nm (3.0 eV), 435 nm (2.8 eV) and 461 nm (2.7 eV). Fig. 4(b) shows a detailed evolution of the PL spectra as λ_{exc} is systematically increases from 370–385 nm in 2 nm steps. The multi-peaked, violet-blue emission intensity grows as λ_{exc} approaches 385 nm, where the intensity maximizes and then steadily decreases for longer wavelengths. This increase in intensity, till 385 nm, is accompanied by a steady decay in the broadband emission at 615 nm and the simultaneous appearance of emission centred around 700 nm. A closer inspection reveals two other important features; firstly the spectral evolution shows a constant emission intensity ($\sim 1.5 \times 10^5$ cps μA^{-1}) around 530 nm, irrespective of λ_{exc} , in the range 350–430 nm, indicating that the higher energy state is uniformly populated by all excitations in this range. Secondly, the spectrum corresponding to $\lambda_{\text{exc}} = 375$ nm exhibits a remarkably flat emission over the entire visible range (400–700 nm) and would serve as an ideal white light converter of UV excitation (see Fig. S1 in ESI†).



Fig. 4 (a–c) Excitation dependent photoluminescence spectra of ZnO/ITO nanorods for different excitation wavelengths. (d) Spectral decomposition of the broadband emission centred at 615 nm, obtained with 370 nm excitation. Components centred at 532 nm (green), 605 nm (orange), 700 nm (maroon) and the envelope (black) are shown.

For excitations with $\lambda_{\text{exc}} > 410$ nm (Fig. 4(c)), the spectra are dominated by a green emission at 530 nm, which decays with increasing λ_{exc} along with the previously evidenced emission in the red (700 nm).

The PL spectra for the Zn rich ZnO/Zn nanorods are shown in Fig. 6(a) for λ_{exc} in the range 340–410 nm. For $\lambda_{\text{exc}} \geq 350$ nm, the NBE peak is essentially unresolved due to the dominant violet-blue emission peaks. For $\lambda_{\text{exc}} = 340$ nm, the spectrum exhibits a shoulder around 375 nm, which on spectral decomposition shows a component at 377 nm (3.3 eV), corresponding to the NBE emission (see Fig. S2 in ESI†). This contrasts with the PL spectra for ZnO/ITO, which are dominated by the NBE emission for super band-gap excitations, with the violet-blue emissions totally absent. For sub-band gap excitations, $\lambda_{\text{exc}} \geq 380$ nm, the spectra qualitatively follow a trend similar to that observed for ZnO/ITO. The most striking similarity between the spectra obtained from each sample is that the family of violet-blue peaks is centred at the same wavelength, even as it is more intense for the Zn rich ZnO/Zn sample (see Table S1 in ESI†). It is worth noting that the appearance of the violet-blue emissions for a small range of excitation wavelengths, corresponding to energies just below E_g , in a direct band gap semiconductor is

indicative of the presence of partially filled electronic states below the CBM.¹⁶

Semi-log plots of PLE spectra for ZnO/ITO are shown in Fig. 5(a) for various detection wavelengths (λ_{det}). For λ_{det} in the range 400–530 nm the spectra are characterized by the presence of a maximum around 382 nm extending into a plateau up to 410 nm. The spectrum for 700 nm shows two distinct peaks at 380 and 420 nm – lying on either side of the plateau evidenced above. The PLE spectra for λ_{det} in the violet-blue range are further characterized by a small but distinct hump around 325 nm (3.75 eV). Fig. 5(b) shows a plot of the excitation wavelength at which the PLE intensity maximizes (λ_{Imax}) versus the corresponding λ_{det} . It demonstrates that the λ_{Imax} can be classified into two groups: (i) those lying around 375 nm, thus matching E_g and (ii) those in the range 380–386 nm, thus showing a maximum at sub- E_g energies. While the former group corresponds to NBE and green emission, the latter corresponds to the violet-blue and the red emissions. This grouping is not accidental but points towards a commonality in their respective emission pathway, as discussed later. The PLE spectra for the Zn rich ZnO/Zn nanorods (Fig. 6(b)) stand in sharp contrast to that of ZnO/ITO, amidst several similarities. Overall, the PLE



Fig. 5 (a) Semi-log plot of photoluminescence excitation spectra for different emission wavelengths for ZnO/ITO nanorods. (b) Position of maximum intensity peak (λ_{max}) for different detection wavelength.

intensity decreases with increasing λ_{exc} for all λ_{det} , unlike that of ZnO/ITO. The spectra for $\lambda_{\text{det}} = 380, 411$ and 435 nm are distinctly characterized by a double peaked structure around 325 nm (3.81 eV), *i.e.* around the same λ_{exc} for which the spectra for ZnO/ITO showed a small hump. The same spectra are further characterized by edges at 382 nm (3.24 eV) and 410 nm (3.0 eV), marked by vertical arrows in the figure. The spectrum for 700 nm again shows a peak at 380 and 420 nm, similar to the observations for ZnO/ITO. Importantly, the spectrum for 700 nm is also characterized by a strong correlation with $\lambda_{\text{exc}} \sim 325$ nm (see Fig. S3 in ESI[†]).

The presence of the violet-blue emissions in a single PL spectrum from an isolated sample of ZnO may only be indicative of sub-CBM localized states, but will not be conclusive proof of the same.^{16,18,32} However, a comprehensive analysis of the entire PL and PLE spectra as presented above and their evolution with λ_{exc} essentially corroborates the presence of these states below the CBM. Structures in the violet-blue PL emission, specifically the highest and lowest energy peaks between 400 – 460 nm, prove the presence of multiple localized states between 2.7 – 3.0 eV, above the VBM. Further, the presence of violet-blue emission for super E_{g} excitations, only from the Zn rich ZnO/Zn sample, and its absence in ZnO/ITO along with its enhanced intensity in the former, reinforce the understanding that these defect states originate from I_{Zn} in ZnO.^{10,16,23,32,33} Now, theoretical band structure calculations have shown that along with the I_{Zn} related defect states below the CBM,^{14,34} there also exist electronic states due to excess Zn in the energy range 3.6 – 4.0 eV above the VBM, essentially lying within the CB.^{9,14} Since I_{Zn}



Fig. 6 (a) Excitation dependent PL spectra and (b) PLE spectra for different emission wavelengths of ZnO/Zn nanorods.

states carry a lone pair of electrons their presence within the CB will essentially result in ionizing the defect state (I_{Zn}^{++}) and doping the undoped ZnO. On the other hand, it is also predicted that the probability of existence of isolated I_{Zn} in the ZnO lattice and isolated V_{O} defects is very low since their formation enthalpies are prohibitively high: ~ 6 eV in the case of the former.⁹ Interestingly, Kim *et al.*⁷ have calculated the formation enthalpy of a complex of V_{O} and doubly ionized I_{Zn}^{++} defect as a function of their mutual separation (d) and shown that the formation enthalpy of the complex is significantly lower. The resulting hybridization between the deep level V_{O} and the shallower I_{Zn} states raises the hybridized I_{Zn}^{++*} state inside the CB and lowers the hybridized V_{O} (V_{O}^*) state further within the band gap. The raising and lowering energies are strong functions of d . The data presented above provides an experimental signature of the existence of these I_{Zn} related states (I_{Zn}^{++*}), within the CB; evidenced as strong PLE peaks around 325 nm (3.8 eV) in the blue-violet spectra (Fig. 6(b)) for the Zn rich ZnO/Zn sample. The weak maximum around 325 nm in ZnO/ITO's PLE spectra (Fig. 5(a)) for the same λ_{det} may also be of a similar origin. The relative strengths of PLE intensity, around 325 nm, are indicative of the relative abundance of I_{Zn} in the respective samples.

Now, as mentioned above, V_O and I_{Zn} may exist within the ZnO lattice for a range of mutual separations and crucially in various oxidation states. Hence, following Kim *et al.*'s study, it is expected that each complex will generate pairs of I_{Zn}^{++*} and V_O^* states differing slightly in energy from every other complex, originating from different separations. For example, a similar hybridization between doubly occupied I_{Zn} states, theoretically calculated to be lying below the CBM¹⁴ and V_O would give rise to multiple localized I_{Zn}^* states just below the CBM, as a function of the separation distance. The I_{Zn}^* states will be raised in energy, closer to the CBM, making them viable donors in undoped ZnO. V_O is the necessary partner of hybridization and is therefore equally important for the n-type doping of ZnO, not only by lowering the formation enthalpy of the complexes but also through raising the energy of the I_{Zn}^* states, close to or within the CB itself.

Present and previous investigations^{16,31,32} suggest e-h recombination between these I_{Zn}^* states and the VB as the origin of violet-blue emissions, in the PL spectra. Further, the evolution of the PL spectra (Fig. 4(a) and (b) and 6(a)) for excitation energies just less than E_g shows a progressively intensifying violet-blue emission, which proves that electrons excited close to the CBM are more likely to transit to the I_{Zn}^* levels than undergo direct excitonic e-h recombination with the VB holes. This strong coupling between the CBM and the I_{Zn}^* states is also evidenced in the PLE spectra of ZnO/ITO for the violet-blue detection wavelengths as a slow rising edge between 370–380 nm. The corresponding spectra for ZnO/Zn (Fig. 6(b)) show a plateau over similar λ_{exc} range. Importantly, the PLE intensity for both samples is finite over this energy range, ~ 100 meV below the CBM, which is comparable to the energy difference between the CBM and the highest energy I_{Zn}^* states. Based on the above discussion, the radiative transitions between the suggested energy states of these ZnO nanorods may be reconstructed as shown in Fig. 7. The VBM is the designated zero of the energy scale and the other energies are as calculated from measurements reported in this study. It is worth mentioning that these I_{Zn}/I_{Zn}^* states are typically localized between 100–600 meV below the CB but the presence of narrow peaks in the violet-blue PL emission suggests that they do not form an

extended defect band. They appear to be a collection of localized states retaining their individual identity – which may be a signature of an array of $I_{Zn}-V_O$ complexes, of varying separation formed within the ZnO lattice.

The PL spectra for excitation energies smaller than E_g show a decaying peak at 615 nm (2.0 eV) simultaneously with an intensifying red emission. Interestingly, this broadband emission centred at 615 nm may be spectrally decomposed to yield three Gaussian peaks at 532 nm, 605 nm and 700 nm (Fig. 4(d)). It is noteworthy that these three peaks are evidenced in the entire PL spectra, for all λ_{exc} ranging from 280–450 nm, what changes is only their relative intensity as a function of λ_{exc} . A similar decomposition is obtained for the corresponding PL spectra for ZnO/Zn. The orange emission (605 nm) has been suggested to emanate from radiative de-excitation from the CBM to deep level states (DL_1) attributed to doubly ionized V_O states (V_O^{++}),^{21,24,35} which are nucleated at surfaces or grain boundaries. While the intensity of the PLE spectrum for ZnO/ITO at $\lambda_{det} = 605$ nm (Fig. 5) shows a maximum at excitation energies matching E_g (around 374 nm), decaying for longer λ_{exc} , the corresponding PLE spectrum for ZnO/Zn shows a monotonic increase in intensity for super band-gap excitation energies (Fig. 6(b)). Both observations conform to the emission pathway suggested above, placing the DL_1 states ~ 2.0 eV below the CBM.

In contrast, the PLE spectra for both samples at $\lambda_{det} = 700$ nm show two peaks at 380 and 420 nm, for sub band-gap excitation energies which favour population of the I_{Zn}^* states, but not the violet-blue emissions. Indeed the red emission decays rapidly for λ_{exc} beyond 420 nm (Fig. 4(c)), inextricably linking it to the I_{Zn} states. Importantly, the energy difference between the orange and red emission peaks is directly comparable to the energy difference between the CB minima and the I_{Zn}^* defect states, ~ 0.3 eV. Based on the above, we conclude that the red emission (700 nm) emanates from radiative de-excitation from the I_{Zn}^* states to the same DL_1 states that participate in the orange emission. It is worth reiterating that although red emission is favoured for excitation energies smaller than E_g , for ZnO/Zn it is also significant for excitation energies larger than E_g , specifically $\lambda_{exc} \sim 325$ nm (ref. 22) (see Fig. S3 in ESI†). Though the green emission, around 530 nm, is observed in the entire PL spectra of both samples, it gains sole prominence for $\lambda_{exc} > 420$ nm (Fig. 4(c)), where the other emissions are subdued. Vanheusden *et al.*²⁰ and Ye *et al.*²⁴ have assigned emissions in this range with recombination of electrons from deep level isolated V_O^+ centers or V_O^+ complex levels with photo-generated holes. Here, the PL peak position is indicative of deep level defect states (DL_2) typically 2.34 eV above the VBM, which are indirectly populated by electron transitions, from the CBM and I_{Zn} defect states. This is further corroborated by the PLE spectra for $\lambda_{det} = 510$ and 530 nm for the Zn rich ZnO/Zn, which shows high emissions for super band-gap excitations, specifically at $\lambda_{exc} \sim 325$ nm (Fig. 6(b)). Notably, Vempati *et al.*³⁵ have reported detectable photoconductivity in indium doped ZnO thinfilms with a 532 nm illumination, directly addressing the DL_2 states.



Fig. 7 Electron band structure and transitions evidenced in the photoluminescence spectra of ZnO nanorods.

Direct evidence of surface related donor states have been recently confirmed through spatially resolved scanning tunneling spectroscopy measurements conducted on single crystals of ZnO.²⁵ The detection of doubly ionizable donor states, within the investigated energy range, is consistent with the presence of I_{Zn} related states at surfaces. Similarly, spatially resolved photoconductivity studies are underway in our group to investigate the effect of I_{Zn} related defect states on the photoconductivity of the samples discussed above, especially in the Zn rich ZnO/Zn nanorods.

4. Conclusions

Highly crystalline ZnO nanorods have been synthesized *via* two low temperature techniques resulting in the stoichiometrically pure ZnO/ITO and Zn rich ZnO/Zn samples. The nanorods with high surface to volume ratio are naturally expected to harbour V_O in the ZnO lattice. The PL spectra are shown to be highly dependent on the excitation energies *vis-à-vis* the defect states present in the band-gap. Excitations with energies close to or just smaller than the E_g result in strong violet-blue emissions, indicating the presence of localized states within 100 meV below the CBM, in both samples. Importantly, PL and PLE spectra provide signature of I_{Zn} related defect states lying within the CB itself, but only in the Zn rich ZnO/Zn sample and not for ZnO/ITO, in agreement with previous theoretical predictions. Since the I_{Zn} defect states carry a lone pair of electrons, their presence just below the CB and crucially within the CB will naturally impart an n-type character to the undoped ZnO. The importance of V_O in conjunction with I_{Zn} in bringing about the n-type conductivity of ZnO has also been discussed in the light of recent theoretical investigations.

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Notes and references

- U. Ozgur, Y. I. Alivov, C. Liu, A. Teke, M. A. Reshchikov, S. Dogan, V. Avrutin, S. J. Cho and H. Morkoc, *J. Appl. Phys.*, 2005, **98**, 041301.
- S. Jeon, S.-E. Ahn, I. Song, C. J. Kim, U. I. Chung, E. Lee, I. Yoo, A. Nathan, S. Lee, J. Robertson and K. Kim, *Nat. Mater.*, 2012, **11**, 301–305.
- D. I. Son, B. W. Kwon, D. H. Park, W.-S. Seo, Y. Yi, B. Angadi, C.-L. Lee and W. K. Choi, *Nat. Nanotechnol.*, 2012, **7**, 465–471.
- K. Bob Jin, K. Jong-Young, C. Soon-Mok and A. Sung Jin, *Nanotechnology*, 2014, **25**, 085701.
- M. Wang, Y. Yang, P. Lan, K. Zhu, J. Huang, Y. Lu, R. Tan and W. Song, *Phys. Status Solidi RRL*, 2014, **8**, 172–175.
- S. B. Zhang, S. H. Wei and A. Zunger, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 2001, **63**, 075205.
- Y.-S. Kim and C. H. Park, *Phys. Rev. Lett.*, 2009, **102**, 086403.
- R. Vidya, P. Ravindran, H. Fjellvåg, B. G. Svensson, E. Monakhov, M. Ganchenkova and R. M. Nieminen, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 2011, **83**, 045206.
- A. Janotti and C. G. Van de Walle, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 2007, **76**, 165202.
- D. C. Look, J. W. Hemsky and J. R. Sizelove, *Phys. Rev. Lett.*, 1999, **82**, 2552–2555.
- J. Sann, J. Stehr, A. Hofstaetter, D. M. Hofmann, A. Neumann, M. Lerch, U. Haboeck, A. Hoffmann and C. Thomsen, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 2007, **76**, 195203.
- A. R. Hutson, *Phys. Rev.*, 1957, **108**, 222–230.
- A. Travlos, N. Boukos and C. Chandrinou, *Phys. Status Solidi B*, 2012, **249**, 560–563.
- P. S. Xu, Y. M. Sun, C. S. Shi, F. Q. Xu and H. B. Pan, *Nucl. Instrum. Methods Phys. Res., Sect. B*, 2003, **199**, 286–290.
- S. Vempati, J. Mitra and P. Dawson, *Nanoscale Res. Lett.*, 2012, **7**, 1–10.
- H. Zeng, G. Duan, Y. Li, S. Yang, X. Xu and W. Cai, *Adv. Funct. Mater.*, 2010, **20**, 561–572.
- M. Wang, Y. Zhou, Y. Zhang, E. J. Kim, S. H. Hahn and S. G. Seong, *Appl. Phys. Lett.*, 2012, **100**, 101906.
- Z. Liang, X. Yu, B. Lei, P. Liu and W. Mai, *J. Alloys Compd.*, 2011, **509**, 5437–5440.
- X. Xu, C. Xu, Z. Shi, C. Yang, B. Yu and J. Hu, *J. Appl. Phys.*, 2012, **111**, 083521–083526.
- K. Vanheusden, W. L. Warren, C. H. Seager, D. R. Tallant, J. A. Voigt and B. E. Gnade, *J. Appl. Phys.*, 1996, **79**, 7983–7990.
- A. v. Dijken, E. A. Meulenlamp, D. L. Vanmaekelbergh and A. Meijerink, *J. Phys. Chem. B*, 2000, **104**, 1715–1723.
- A. B. Djurišić, Y. H. Leung, K. H. Tam, Y. F. Hsu, L. Ding, W. K. Ge, Y. C. Zhong, K. S. Wong, W. K. Chan, H. L. Tam, K. W. Cheah, W. M. Kwok and D. L. Phillips, *Nanotechnology*, 2007, **18**, 095702.
- K. H. Tam, C. K. Cheung, Y. H. Leung, A. B. Djurišić, C. C. Ling, C. D. Beling, S. Fung, W. M. Kwok, W. K. Chan, D. L. Phillips, L. Ding and W. K. Ge, *J. Phys. Chem. B*, 2006, **110**, 20865–20871.
- J. D. Ye, S. L. Gu, F. Qin, S. M. Zhu, S. M. Liu, X. Zhou, W. Liu, L. Q. Hu, R. Zhang, Y. Shi and Y. D. Zheng, *Appl. Phys. A: Mater. Sci. Process.*, 2005, **81**, 759–762.
- H. Zheng, J. Kröger and R. Berndt, *Phys. Rev. Lett.*, 2012, **108**, 076801.
- L. E. Greene, M. Law, D. H. Tan, M. Montano, J. Goldberger, G. Somorjai and P. Yang, *Nano Lett.*, 2005, **5**, 1231–1236.
- Y.-Y. Lin, C.-W. Chen, W.-C. Yen, W.-F. Su, C.-H. Ku and J.-J. Wu, *Appl. Phys. Lett.*, 2008, **92**, 233301–233303.
- Z. Zhang, H. Yu, X. Shao and M. Han, *Chem.-Eur. J.*, 2005, **11**, 3149–3154.
- P. Erhart and K. Albe, *Appl. Phys. Lett.*, 2006, **88**, 201918.
- K. Kanaya and S. Okayama, *J. Phys. D: Appl. Phys.*, 1972, **5**, 43.
- B. Cao, W. Cai and H. Zeng, *Appl. Phys. Lett.*, 2006, **88**, 161101–161103.

- 32 C. H. Ahn, Y. Y. Kim, D. C. Kim, S. K. Mohanta and H. K. Cho, *J. Appl. Phys.*, 2009, **105**, 013502–013505.
- 33 S. A. M. Lima, F. A. Sigoli, M. Jafelicci Jr and M. R. Davolos, *Int. J. Inorg. Mater.*, 2001, **3**, 749–754.
- 34 P. Erhart, K. Albe and A. Klein, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 2006, **73**, 205203.
- 35 S. Vempati, S. Chirakkara, J. Mitra, P. Dawson, K. K. Nanda and S. B. Krupanidhi, *Appl. Phys. Lett.*, 2012, **100**, 162104.